

Analysis of pull-in Instability in Cantilever Microbeam

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Abstract: We make the static pull-in parameters of electro statically incited decreased width little scale cantilever bar. A computationally profitable single level of-flexibility model is utilized as a part of the setting of Ritz essentialness framework to clear the static attract parameters of the scattered electromechanical model that considers the impacts of flanking field capacitance. The exactness of this single dof show together with the variable-width likeness the Palmer's outlining model is set up through an examination with 3D obliged part reenactments. An interesting surface fitting model is proposed to depict the groupings of both the attract dislodging and attract voltage, over a sensibly wide combination of framework parameters. Idealize coefficients of the proposed surface fitting model are secured utilizing nonlinear apostatize examination. A superb understanding shows that the proposed associations are agreeably right to be securely utilized for the electromechanical plan of decreased little scale cantilever bars.

I. INTRODUCTION

Electro statically actuated micro devices constitute an expansive class of the rising micro system innovation attributable to their similarity with micro fabrication forms and ideal scaling properties at the micro scale. A large portion of the electro statically impelled micro devices are helpless to an operational unsteadiness, known as draw in which comes about because of the electrostatic- versatile constrain collaboration[1]. Since draw in speaks to an operational limit, an precise forecast of the basic incitation voltage and the coming about uprooting (by and large named as the pull- in parameters) is essential in the outline of electrostatic micro actuators [2 – 5]. Since the geometry of microactuator impacts both; and induced that the onset of pull -in unsteadiness can be considerably deferred by reasonably changing the actuator width and substantiated this surmising for the cases including deformable anodes [6 – 9]. the essential rationale in choosing the varieties in shaft width (as opposed to in thickness) is the similarity with micro fabrication forms, which permit the generation of self-assertively complex planar geometries without expanding the assembling costs. A basic estimation to the pull-in parameters of non uniform pillars. In such manner, the closed-form empirical formulae created by relate to micro cantilever bars, whose width increment towards the free-end [10-14]. we break down the instance of isotropic Euler- Bernoulli cantilever bars having straightly changing width, The introduce examination considers the impact of bordering field capacitance which is portrayed by the periphery parameter[15-18].

The database of dimensionless static pull- in parameters over a sensibly extensive variety of decrease and We have made novel close casing accurate relations to anticipate the

static attract parameters of electro statically actuated straightforwardly diminished small scale cantilever shafts. With reference to a growing energy for manhandling the geometric non consistency of the smaller scale bars to redesign the contraption execution, the proposed observational relations can fill in as a profitable gadget to the MEMS originators to assess, at the preliminary blueprint mastermind, the static attract parameters of specifically diminished miniaturized scale pillars. Ritz essentialness technique has been successfully associated with make the indispensable database of dimensionless static pull-in parameters, for contrasting estimations of reduction and outskirts parameters. Pull-in migration is seen to be with respect to the extension in the estimation of lessening parameter and decrease in the estimation of the outskirts parameter. Very convincing is the quantitative evidence of the propriety of using diminished miniaturized scale cantilevers in applications where an enhanced travel range is required. In development to finding the assessments of static attract parameters for a given miniaturized scale actuator, our correct relations can be beneficially used to deal with an inverse issue of arranging the estimations of the smaller scale shaft for a predefined essential of attract expulsion and additionally voltage. The proposed relations, being constant over the picked extent of structure parameters, can in like manner be used to assess the affectability of attract parameters with respect to the diminishing and fringe parameters.

II. FORMULATION AND PROBLEM ANALYSIS

Figure 1, demonstrates a schematic of an electro statically activated, slim, and straightly decreased micro cantilever

beam made up of a direct versatile material having Young's modulus \hat{E} furthermore, Poisson's proportion $\hat{\nu}=\nu$ All through this article, all $(\hat{\cdot})$ terms demonstrate the amounts having physical units. \hat{L} and \hat{h} indicate length and thickness of the microbeam, individually. $\hat{b}(\hat{x})$ indicates the width of the microbeam at a separation of \hat{x} from the settled end as appeared in the schematic. $\hat{I}(\hat{x})$ signifies the range snapshot of dormancy of the cross-area, which is a function of \hat{x} . At first, the micro beam (movable electrode) and the base settled anode are isolated by a remove equivalent to \hat{g}_o , and the permittivity of free space between them is $\hat{\epsilon}_o$. The successful Young's modulus of the micro beam material is signified by \hat{E}^* . If there should arise an occurrence of wide ($\hat{b} \geq 5\hat{h}$) micro beams, $\hat{E}^* = \hat{E}/(1 - \hat{\nu})$ and for limited ($\hat{b} < 5\hat{h}$) microbeams, $\hat{E}^* = \hat{E}$ [19]. The width at the settled end of the cantilever bar is \hat{b}_o which straightly decreases to $\hat{b}_o(1 - f)$ at its free end. The direct width variety is described by the decrease parameter f , and communicated as

$$\hat{b}(\hat{x}) = b_o z(\hat{x}) = b_o(1 - f \frac{\hat{x}}{\hat{L}}) \quad (1)$$

where $w(\hat{x})$ speaks to the scaling of \hat{b}_o as for the length arrange \hat{x} . In the present examination, we expect that the potential distinction \hat{V} between the two anodes is connected gradually with the end goal that the impact of inertial terms can be dismissed. In such a case, the portable cathode encounters an operational flimsiness (pull-in) at a specific estimation of the connected voltage, past which, it strikes into the settled base terminal [19-20]. The basic connected voltage (pull-in voltage) and the comparing most extreme relocation (pull-in relocation) of the versatile terminal are as one named as the static draw in parameters of the micro beam. We indicate the static draw in dislodging by \hat{u}_{ps} and the relating static draw in voltage by \hat{V}_{ps} . Taking after Euler-Bernoulli hypothesis of slim pillars.

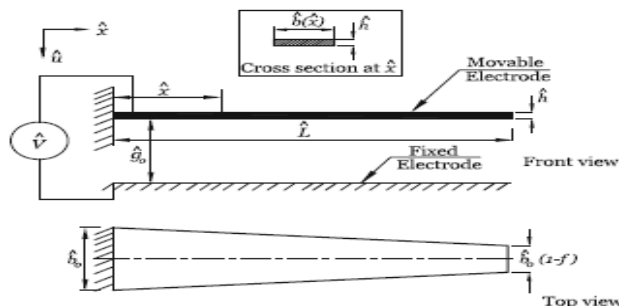


Fig.1 schematic of an electrostatically actuated linearly tapered micro cantilever beam

The governing differential equation of the actuator depicted in

Fig. 1 is written as

$$F_e = \frac{E^* b_o h^3}{12} \frac{d^2}{dx^2} \left[z(\hat{x}) \frac{d^2 \hat{w}}{dx^2} \right] \quad (2)$$

the moment of inertia of the cross-section ($I = \frac{bh^3}{12}$) and $w(\hat{x})$ where represents the deflection of micro cantilever under the activity of the dispersed electrostatic load which is indicated by \hat{F}_e . The relocation arrangement $w(\hat{x})$ needs to fulfill the accompanying four limit conditions:

$$Z|_{\hat{x}=0} = 0, \quad \frac{d\hat{w}}{d\hat{x}}|_{\hat{x}=0} = 0, \quad \frac{d^2 \hat{w}}{d\hat{x}^2}|_{\hat{x}=\hat{L}} = 0, \quad \frac{d^3 \hat{w}}{d\hat{x}^3}|_{\hat{x}=\hat{L}} = 0. \quad (3)$$

For a prismatic beam having steady width \hat{b} , the expression for appropriated electrostatic compel utilizing the Palmer's model of bordering field capacitance is composed as potential energy equal to work required to electric charge to an attractive force can be derived by ($U=F$) where

$C = \frac{\epsilon b}{g} \left(1 + 2 \frac{g}{\pi b} \right)$ where c is capacitance when load applied on the beam which is free one end then deflection is w .

$$\hat{F}_e = \frac{\hat{\epsilon}_o \hat{b} V^2}{2(\hat{g}_o - \hat{w})(\hat{g}_o + \hat{w})} \left(1 + \frac{2(\hat{g}_o - \hat{w})}{\pi \hat{b}} \right) \quad (4)$$

In the present examination, we utilize the accompanying variable-width likeness this fringing model by supplanting the term of constant width \hat{b} by the variable width $\hat{b}(\hat{x}) = \hat{b}_o z(\hat{x})$

$$\hat{F}_e = \frac{\hat{\epsilon}_o \hat{b}_o V^2 z(\hat{x})}{2(\hat{g}_o - \hat{w})^2} \left(1 + \frac{2(\hat{g}_o - \hat{w})}{\pi \hat{b}_o z(\hat{x})} \right) \quad (5)$$

where $z(\hat{x})$ is scaling of \hat{b}_o width respect to length coordinate of x .

By considering an instance of sharp triangular shaft ($f = 1$) and prismatic ($f = 0$). Keeping in mind the end goal to sum up the resulting investigation, we characterize the accompanying dimensionless amounts:

$$w(x) = \frac{\hat{w}(\hat{x})}{\hat{g}_o}, \quad x = \frac{\hat{x}}{\hat{L}}, \quad V^2 = \frac{6\hat{\epsilon}_o \hat{L} \hat{V}^2}{\hat{E}^* \hat{h}^3 \hat{g}_o^3}, \quad C = \frac{\hat{b}_o}{\hat{g}_o} \quad (6)$$

where ζ is from this point forward alluded to as the fringe parameter which administers the degree of fringing field capacitance. The definitions expressed in Eq. 6 reduce Eq. 2 and Eq. 5 to the taking after dimensionless frame:

$$F_e = \frac{E^* b_o h^3}{12} \frac{d^2}{dx^2} \left[z(\hat{x}) \frac{d^2 \hat{w}}{dx^2} \right] = \frac{\hat{\epsilon}_o \hat{b}_o \hat{V}^2 z(\hat{x})}{2(\hat{g}_o - \hat{w})^2} \left(1 + \frac{2(\hat{g}_o - \hat{w})}{\pi \hat{b}_o z(\hat{x})} \right) \quad (7)$$

so the equation is

$$\frac{d^2}{dx^2} \left(z(x) \frac{d^2 w}{dx^2} \right) = \frac{V^2 z(x)}{(1-w)^2} \left(1 + \frac{2(1-w)}{\pi \zeta z(x)} \right) \quad (7)$$

where $z(x) = 1 - fx$ is the dimensionless explanation of the width work. The four boundary conditions are communicated in their dimensionless shape as

$$Z|_{x=0} = 0, \quad \frac{dw}{dx}|_{x=0} = 0, \quad \frac{d^2w}{dx^2}|_{x=1} = 0, \quad \frac{d^3w}{dx^3}|_{x=1} = 0, \quad (8)$$

When all is said in done, the static pull-in removal and static pull in voltage corresponding to Eq. 7 are functions of both, the taper parameter f and the fringe parameter ζ .

III. NUMERICAL SIMULATION FOR PULL-IN VOLTAGE

Obtaining a correct answer for the governing differential condition (Eq. 7) is a troublesome undertaking and hence, the articulations of static pull-in parameters can't be obtained analytically. Specialists often fall back on different numerical methods to accomplish this undertaking. the use of Ritz energy technique to Eq. 7 does not require any information of the dimensional framework parameters. Subsequently, with an intent to produce a database of dimensionless pull-in parameters, we utilize the Ritz energy technique in our analysis. The methodology of this technique for a nonexclusive combination of f and ζ is introduced in the following. The total potential energy Π_T of the electrostatic-elastic system depicted in Fig. 1 is written as

$$\text{strain energy per unit length } U_L = \frac{1}{2} \frac{E}{dx^2} \int y^2 dA$$

where $\int y^2 dA = \text{moment of inertia } (I)$

work potential(external) $w_p = \int_0^L p w dx$,

but energy store in the capacitor so work external = $\int_0^L \frac{1}{2} CV^2$

$$\Pi_T = \frac{\hat{E}^* \hat{b}_o \hat{h}^3}{24} \int_0^L \left(z(\hat{x}) \left(\frac{d^2 \hat{w}}{d\hat{x}^2} \right)^2 \right) d\hat{x} - \frac{\hat{V}^2}{2} \int_0^L \left(\frac{\hat{\epsilon}_o \hat{b}_o z(\hat{x})}{(\hat{\theta}_o - \hat{w})} + \frac{2\hat{\epsilon}_o}{\pi} \left(1 + \ln \left[\frac{\pi \hat{b}_o z(\hat{x})}{(\hat{\theta}_o - \hat{w})} \right] \right) \right) d\hat{x} \quad (9)$$

The dimensionless definitions expressed in Eq. 6, diminish Eq. 9 to the following dimensionless frame:

$$\Pi_T = \frac{12 \hat{\Pi}_T \hat{I}^3}{\hat{E}^* \hat{b}_o \hat{h}^3 \hat{g}_o^2} = \frac{1}{2} \int_0^1 \left(z(x) \left(\frac{d^2 w}{dx^2} \right)^2 \right) dx - V^2 \int_0^1 \left(\frac{z(x)}{(1-w)} + \frac{2}{\pi \zeta} \left(1 + \ln \left[\frac{\pi \zeta z(x)}{(1-w)} \right] \right) \right) dx \quad (10)$$

The normalized dislodging of the micro beam $z(x)$ is approximated by the accompanying function:

$$W(x) = \alpha \phi(x) \quad (11)$$

where $\phi(x)$ is a known dislodging trial function fulfilling every one of the four mechanical limit conditions

$$\phi(x) = 6x^2 - 4x^3 + x^4 \quad (12)$$

A few analysts have utilized the previously mentioned trial capacity to assess the static pull-in parameters of kaleidoscopic micro beams. In the up and coming segment, it will be demonstrated that the trial work expressed in Eq. 12 is similarly productive in portraying the electrostatic-elastic conduct of non prismatic cantilever shafts

$$\frac{d\Pi_T}{da} = 0, \quad \frac{d^2\Pi_T}{da^2} = 0 \quad (13)$$

For given estimations of f and ζ , the two conditions expressed in Eq. 13 frame an arrangement of nonlinear concurrent equations, involving two factors, that are an and V . Eliminating V from the two conditions expressed in Eq. 13 drives us to the following pull-in equation:

Differentiate the equation (10) w r t a

$$\int_0^1 \frac{z(x)\phi}{(1-\alpha\phi)^2} \left[1 + \frac{2(1-\alpha\phi)}{\pi\zeta z(x)} \right] dx - a \left(\int_0^1 \frac{2z(x)\phi^2}{(1-\alpha\phi)^3} \left[1 + \frac{(1-\alpha\phi)}{\pi\zeta z(x)} \right] dx \right) = 0 \quad (14)$$

The physically feasible arrangement of Eq. 14 is meant by a_{PS} , which when increased by $\phi(x)$, portrays the avoidance profile of the cantilever bar at static pull-in. The standardized static pull-in displacement Q_{PS} can now be obtained as the most extreme avoidance of the cantilever beam occurring at the point of static pull-in. This is communicated as,

$$Q_{PS} = a_{PS} \phi|_{x=1} \quad (15)$$

The basic connected voltage (dimensionless static pull-in voltage V_{PS}) corresponding to a_{PS} is obtained from the following condition, which is a rehashing of the principal arrange condition expressed in Eq. 13 and assessed at a_{PS} :

$$V_{PS} = \sqrt{\frac{a_{PS} \int_0^1 \left((1-fx) \left(\frac{d^2 \phi}{dx} \right)^2 \right) dx}{\int_0^1 \frac{(1-fx)\phi}{(1-a_{PS}\phi)^2} \left[1 + \frac{2(1-a_{PS}\phi)}{\pi\zeta(1-fx)} \right] dx}} \quad (16)$$

The dimensional partners of ups and Vps can be determined using the dimensionless definitions expressed in Eq. 6. The previously mentioned technique in view of the Ritz vitality procedure can be utilized to obtain the assessments of static pull-in parameters for any given estimations of f and ζ .

IV. RESULTS AND DISCUSSIONS

This area is sorted out in two sections. Initially, by considering normal cases of kaleidoscopic and sharp triangular shafts, we evaluate the pertinence of: the variable-width likeness Palmer's fringing model, and the fourth request displacement trial work, in predicting the static pull-in parameters of non prismatic micro beams.

V. TEST CASES: PRISMATIC BEAMS

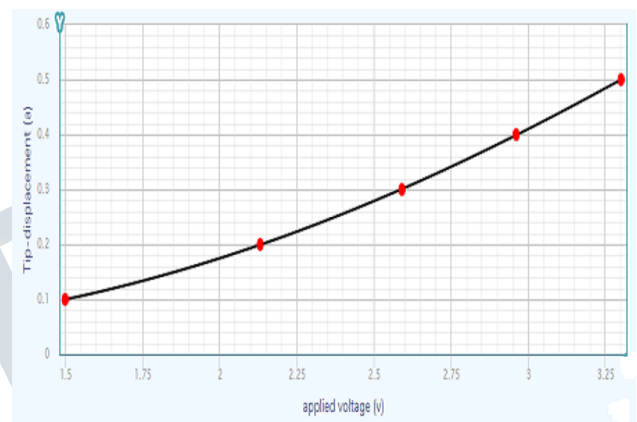
Consider the following measurements and parameters of an ordinary kaleidoscopic micro cantilever shaft .

$$\hat{L} = 100 \mu\text{m}, \quad b = 50 \mu\text{m}, \quad \hat{h} = 3.0 \mu\text{m}, \quad \hat{g}_o = 1.0 \mu\text{m}, \quad \hat{E} = 169 \times 10^9 \text{ N/m}, \quad \nu = 0.06, \\ \hat{\epsilon}_o = 8.854 \times 10^{-12} \text{ F/m}.$$

Notwithstanding this instance of kaleidoscopic shaft, we consider a sharp triangular shaft, having settled end width equivalent to $50 \mu\text{m}$, which linearly decreases to zero at the free end. speaks to an outrageous instance of the linear width variety ($f = 1$), for prismatic ($f = 0$), We execute Ritz vitality method depicted in the past area to obtain the static pull -in parameters of both setups (i.e., the kaleidoscopic and the sharp triangular pillar) Keeping in mind the end goal to approve the consequences of Ritz system, 3D finite component investigations are performed in . Table 1 shows an examination between the appraisals of static pull-in parameters obtained using Ritz system and finite component reenactments. A nearby assention between the two bends for each situation (kaleidoscopic and sharp triangular), together with the numerical information exhibited in Table 1, drives us to the two imperative inferences. the variable-width likeness Palmer's fringing model can precisely depict the electrostatic flexible conduct of non prismatic shafts. the fourth request polynomial trial work (expressed in Eq. 12) can precisely foresee the static pull-in parameters of non prismatic shafts. In view of these inferences, we now apply the Ritz vitality procedure to do a point by point parametric investigation of static pull-in parameters involving varieties in the decrease and fringe parameters.

Table 1: Comparison of the estimates of static pull-in parameters obtained using Ritz energy technique and finite element simulations.

Configuration	Pull-in displacement (sharp triangular)	Pull-in voltage (sharp triangular)
Present work (Ritz technique)	.5646	74.622
m m joglekar [8]	.565	74.627



VI. CONCLUSION

We have made novel close casing accurate relations to anticipate the static attract parameters of electro statically actuated straightforwardly diminished small scale cantilever shafts. With reference to a growing energy for manhandling the geometric non consistency of the smaller scale bars to redesign the contraction execution, the proposed observational relations can fill in as a profitable gadget to the MEMS originators to assess, at the preliminary blueprint mastermind, the static attract parameters of specifically diminished miniaturized scale pillars. Ritz essentialness technique has been successfully associated with make the indispensable database of dimensionless static draw in parameters, for contrasting estimations of reduction and outskirts parameters. Pull-in migration is seen to be with respect to the extension in the estimation of lessening parameter and decrease in the estimation of the outskirts parameter. Very convincing is the quantitative evidence of the propriety of using diminished miniaturized scale cantilevers in applications where an enhanced travel range is required. In development to finding the assessments of static attract parameters for a given miniaturized scale actuator, our correct relations can be beneficially used to deal with an

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